Intellectual Property Network

IPN Home | Search | Order | Shopping Cart | Login | Site Map | Help





JP6036966A2: THIN FILM CAPACITOR

View Images (1 pages) | View INPADOC only

Country:

JP Japan

Kind:

Inventor(s):

NAKANE TAKASHI YAGISHITA HIROSHI NOZOE SHOICHI SUZUKI MIKIO SHINODA YOSHIRO **MIYASOTO MASAHIDE**

Applicant(s):

KOGYO GIJIYUTSUIN KAGAKU GIJUTSU KENKYUSHO

RUBIKON DENSHI KK

News, Profiles, Stocks and More about this company

Issued/Filed Dates:

Feb. 10, 1994 / May 26, 1992

Application Number:

JP1992000133662

IPC Class:

H01G 4/06; H01B 3/30; H01G 4/30; C08G 18/32; C08G 69/42; C08G 73/10;

Abstract:

Purpose: To obtain a thin film capacitor capable of further improving electric characteristics determined from the

characteristics of a polymer layer formed as dielectric substance by

a vapor deposition polymerization method

Constitution: A thin film capacitor 1 is provided with a substrate 2 on which multilayered structure 5 constituted of film type inner electrodes 3a, 3b, 3c and film type dielectric substance 4a, 4b is formed. The dielectric substance 4a, 4b is composed of a polymer

film of phloroalkylated aromatic polyimide containing Nmethylacridimium-7,7,8,8-tetracyanoquino dimethane complex (which is called 'TCNQ complex' hereafter). The polymer film of pholoroalkylated aromatic polyimide containing the TCNQ complex is formed by a vapor deposition polymerization method applying the following to evaporation source material; monomer of 2-2 bis (4aminophenyl) hexaphloropropane, monomer of pyromellitic

dihydride and crystal of TCNQ complex. COPYRIGHT: (C)1994, JPO& Japio

Other Abstract Info:

DERABS C94-087082 DERC94-087082

Foreign References:

(No patents reference this one)

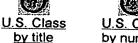
Powered by **U** and Net.Data

Nominate this invention for the Gallery... Alternative Searches

Patent Number







by number



EST AVAILABLE COPY

Browse





(11) Publication number:

06036966

Generated Document.

PATENT ABSTRACTS OF JAPAN

(21) Application number: **04133662**

(22) Application date: **26.05.92**

(51) Intl. Cl.: H01G 4/06 H01B 3/30 H01G 4/30

(30) Priority:

(43) Date of application

publication:

10.02.94

(84) Designated contracting

states:

(71) Applicant: KOGYO GIJIYUTSUIN KAGAKU GIJUTSU KENKYUSHO

RUBIKON DENSHI KK

(72) Inventor: NAKANE TAKASHI

YAGISHITA HIROSHI NOZOE SHOICHI

SUZUKI MIKIO SHINODA YOSHIRO

MIYASOTO MASAHIDE

(74) Representative:

(54) THIN FILM CAPACITOR

(57) Abstract:

PURPOSE: To obtain a thin film capacitor capable of further improving electric characteristics determined from the characteristics of a polymer layer formed as dielectric substance by a vapor deposition polymerization method.

CONSTITUTION: A thin film capacitor 1 is provided with a substrate 2 on which multilayered structure 5 constituted of film type inner electrodes 3a, 3b, 3c and film type dielectric substance 4a, 4b is formed. The dielectric substance 4a, 4b is composed of a polymer film of phloroalkylated aromatic polyimide containing N-methylacridimium-7,7,8,8-tetracyanoquino dimethane complex (which is called 'TCNO complex' hereafter). The polymer film of pholoroalkylated aromatic polyimide containing the TCNO complex is formed by a vapor deposition polymerization method applying the following to evaporation source material; monomer of 2-2 bis (4-aminophenyl) hexaphloropropane,

